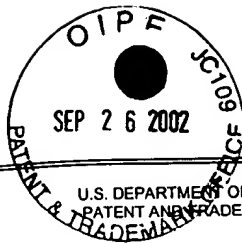




Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 193792US25		SERIAL NO. 09/730,592	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT James M. FITZPATRICK			
				FILING DATE December 7, 2000		GROUP 2161	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
	AO						
	AP						
	AQ						
	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
AFC		AW M. NEGIN, et al., Computer (online), vol. 33, no. 2, pages 2-7, "AN IRIS BIOMETRIC SYSTEM FOR PUBLIC AND PERSONAL USE", February 2000					
		AX					
		AY					
		AZ					
Examiner <i>Diana Charles</i>					<input type="checkbox"/> Additional References sheet(s) attached		
					Date Considered <i>2/2/04</i>		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

am PTO 1449  
(Modified)U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICE

ATTY DOCKET NO.

193792US25

SERIAL NO.

09/730,592

## LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

James M. FITZPATRICK

FILING DATE

December 7, 2000

GROUP

2161

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
DFC	AA	4,992,940	02/12/91	R. E. DWORKIN			
	AB	5,873,069	02/16/99	D. G. REUHL, et al.			
	AC	6,078,891	06/20/2000	J. RIORDAN, et al.			
	AD	6,292,786	09/18/2001	D. W. DEATON, et al.			
	AE	2002/0035549 A1	03/21/2002	Y. HAGIO, et al.			
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
	AO					
	AP					
	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

DFC	AW	M. NEGIN, et al., Computer (online), vol. 33, no. 2, pages 2-7, "AN IRIS BIOMETRIC SYSTEM FOR PUBLIC AND PERSONAL USE", February 2000 (page 5 will be filed later)
DFC	AX	Airaffair.com (online), 2 pages, "THE AIR AFFAIR FUEL PRICE DATABASE", June 14, 2000
DFC	AY	Trak Systems (online), 10 pages, "TRAK SYSTEMS RECORDTRAK SOFTWARE INFORMATION", 2000
	AZ	

☐ Additional References sheet(s) attached

Examiner

Date Considered

2/2/01

\*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

DEC 31 2002  
PATENT & TRADEMARK OFFICE

Form PTO 1449  
(Modified)

U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICE

ATTY DOCKET NO.  
193792US25

SERIAL NO.  
09/730,592

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT  
James M. FITZPATRICK

FILING DATE  
December 7, 2000

GROUP  
2161

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO
	AO				
	AP				
	AQ				
	AR				
	AS				
	AT				
	AU				
	AV				

RECEIVED  
JAN 06 2003  
GROUP 3-00

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

AW	M. NEGIN, et al., Computer (online), vol. 33, no. 2, pages 2-7, "AN IRIS BIOMETRIC SYSTEM FOR PUBLIC AND PERSONAL USE", February 2000
AX	
AY	
AZ	

Examiner

*Diana Charles*

☐ Additional References sheet(s) attached

Date Considered 2/2/04

Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.